

Nonstationary Panels

Based on chapters 12.1, 12.2, and 12.3 of Baltagi, B. (2005): Econometric Analysis of Panel Data, 3rd edition. Chichester, John Wiley&Sons.

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Econometric Methods for Panel Data

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Levin, Lin and Chu (LLC) test I

- Levin, Lin and Chu (2002)
- Idea:
individual unit root tests with limited power against near unit root processes, especially in small samples
→ thus use increased sample size of panel data
- Null hypothesis:
each individual time series contains a unit root
- Alternative hypothesis:
each individual time series is stationary
- Maintained hypothesis, analogous to Dickey-Fuller, but double-indexed:
 - 1 without constant or trend:

$$\Delta y_{it} = \rho y_{i,t-1} + \sum_{L=1}^{p_i} \theta_{iL} \Delta y_{i,t-L} + \varepsilon_{it} \quad (1)$$

Levin, Lin and Chu (LLC) test II

2 with constant:

$$\Delta y_{it} = \rho y_{i,t-1} + \sum_{L=1}^{p_i} \theta_{iL} \Delta y_{i,t-L} + \alpha_i + \varepsilon_{it} \quad (2)$$

3 with constant and trend:

$$\Delta y_{it} = \rho y_{i,t-1} + \sum_{L=1}^{p_i} \theta_{iL} \Delta y_{i,t-L} + \alpha_i' \begin{pmatrix} 1 \\ t \end{pmatrix} + \varepsilon_{it} \quad (3)$$

where α_i is the vector of coefficients corresponding to a constant and a trend component

■ Three-step procedure:

Levin, Lin and Chu (LLC) test III

- 1 perform separate augmented Dickey-Fuller (ADF) regressions for each cross-section i :

$$\Delta y_{it} = \rho_i y_{i,t-1} + \sum_{L=1}^{p_i} \theta_{iL} \Delta y_{i,t-L} + \alpha'_{mi} d_{mt} + \varepsilon_{it} \quad m = 1, 2, 3 \quad (4)$$

where m corresponds to the model without constant or trend ($d_{1t} = 0$), with constant ($d_{2t} = 1$), and with constant and trend ($d'_{3t} = (1, t)$), respectively.

- 1.1 determine lag order to completely specify the ADF regression:
choose p_{max} and use t-statistic of $\hat{\theta}_{iL}$ to decide whether smaller order is to be preferred (t-statistic of $\hat{\theta}_{iL}$ is distributed $N(0,1)$ under $H_0 : \theta_{iL} = 0$)
- 1.2 get orthogonalized residuals to use Frisch-Waugh theorem:
regress Δy_{it} on $\Delta y_{i,t-L}$ for $L = 1, \dots, p_i$ and d_{mt}
→ residuals $\hat{\varepsilon}_{it}$
regress $y_{i,t-1}$ on $\Delta y_{i,t-L}$ for $L = 1, \dots, p_i$ and d_{mt}
→ residuals $\hat{v}_{i,t-1}$

Levin, Lin and Chu (LLC) test IV

1.3 standardize residuals to control for different variances across i :

$$\tilde{\epsilon}_{it} = \frac{\hat{\epsilon}_{it}}{\hat{\sigma}_{\epsilon i}} \quad (5)$$

and

$$\tilde{\nu}_{i,t-1} = \frac{\hat{\nu}_{i,t-1}}{\hat{\sigma}_{\epsilon i}} \quad (6)$$

where $\hat{\sigma}_{\epsilon i}$ is the standard error from each ADF regression for $i = 1, \dots, N$

2 estimate the ratio of long-run to short-run standard deviations:

2.1 long-run variance under H_0 :

$$\hat{\sigma}_{yi}^2 = \frac{1}{T-1} \sum_{t=2}^T \Delta y_{it}^2 + 2 \sum_{L=1}^{\bar{K}} w_{\bar{K}L} \left[\frac{1}{T-1} \sum_{t=2+L}^T \Delta y_{it} \Delta y_{i,t-L} \right] \quad (7)$$

where $w_{\bar{K}L} = L/(\bar{K} + 1)$ for a Bartlett kernel

2.2 short-run variance:

$$\hat{\sigma}_{\epsilon i}^2 \quad (8)$$

Levin, Lin and Chu (LLC) test V

2.3 ratio:

$$\hat{s}_i = \frac{\hat{\sigma}_{yi}}{\hat{\sigma}_{\varepsilon i}} \quad (9)$$

which is a "standardized" standard deviation; the average standard deviation is then

$$\hat{S}_N = \frac{1}{N} \sum_{i=1}^N \hat{s}_i \quad (10)$$

3 calculate the panel test statistics:

3.1 run the pooled regression:

$$\tilde{e}_{it} = \rho \tilde{v}_{i,t-1} + \tilde{\varepsilon}_{it} \quad (11)$$

based on $N\tilde{T}$ observations where $\tilde{T} = T - \bar{p} - 1$ is the average number of observations per individual where \bar{p} is the average lag order

Levin, Lin and Chu (LLC) test VI

3.2 calculate the conventional t-statistic under $H_0 : \rho = 0$:

$$t_\rho = \frac{\hat{\rho}}{\hat{\sigma}(\hat{\rho})} \quad (12)$$

where

$$\hat{\rho} = \frac{\sum_{i=1}^N \sum_{t=2+p_i}^T \tilde{\nu}_{i,t-1} \tilde{\epsilon}_{it}}{\sum_{i=1}^N \sum_{t=2+p_i}^T \tilde{\nu}_{i,t-1}^2} \quad (13)$$

and

$$\hat{\sigma}(\hat{\rho}) = \frac{\hat{\sigma}_{\tilde{\epsilon}}}{\left[\sum_{i=1}^N \sum_{t=2+p_i}^T \tilde{\nu}_{i,t-1}^2 \right]^{\frac{1}{2}}} \quad (14)$$

where

$$\hat{\sigma}_{\tilde{\epsilon}}^2 = \frac{1}{N\tilde{T}} \sum_{i=1}^N \sum_{t=2+p_i}^T (\tilde{\epsilon}_{it} - \hat{\rho} \tilde{\nu}_{i,t-1})^2 \quad (15)$$

is the estimated variance of $\tilde{\epsilon}_{it}$

3.3 calculate the adjusted t-statistic:

$$t_\rho^* = \frac{t_\rho - N\tilde{T}\hat{S}_N\hat{\sigma}_{\tilde{\epsilon}}^{-2}\hat{\sigma}(\hat{\rho})\mu_{m\tilde{T}}^*}{\sigma_{m\tilde{T}}^*} \quad (16)$$

where $\mu_{m\tilde{T}}^*$ and $\sigma_{m\tilde{T}}^*$ are adjustments suggested and tabulated by LLC

Levin, Lin and Chu (LLC) test VII

■ Asymptotic distribution of t_ρ^* :

- $N(0,1)$, which is different from univariate unit root tests converging to functionals of Brownian motions
- requires $\sqrt{N_T}/T \rightarrow 0$ where N is an arbitrary monotonically increasing function of T

■ Limitations:

- assumes cross-sectional independence, problem in macro panels
- does not assume $T \rightarrow \infty$ at a faster rate than $N \rightarrow \infty$ which would be sufficient but not necessary, then problem in micro panels
- assumes ρ homogeneous across i , all cross-sections have or do not have a unit root, "every country converges at the same rate"

■ Recommendations:

- for panels of moderate size ($10 < N < 250$, $25 < T < 250$)
- for very large T , individual unit root tests are sufficiently powerful
- for very large N and very small T , use standard procedures

Im, Pesaran and Shin (IPS) test I

- Im, Pesaran and Shin (2003)

- Idea:

LLC requires ρ to be homogeneous across i , implying convergence at the same rate for all i under the alternative

→ allow ρ to be heterogeneous across i

- Null hypothesis:

$$H_0 : \rho_i = 0 \quad \text{for all } i \quad (17)$$

- Alternative hypothesis:

$$H_1 : \begin{cases} \rho_i < 0 & \text{for } i = 1, 2, \dots, N_1 \\ \rho_i = 0 & \text{for } i = N_1 + 1, \dots, N \end{cases} \quad (18)$$

where the fraction of stationary individual time series is assumed nonzero (necessary for the consistency of the test)

Im, Pesaran and Shin (IPS) test II

- Test statistic:

$$\bar{t} = \frac{1}{N} \sum_{i=1}^N t_{\rho i} \quad (19)$$

where $t_{\rho i}$ is the t-statistic from the individual ADF regressions for all i

→ "average of the individual ADF statistics"

- Standard result:

$$t_{\rho i} \Rightarrow \frac{\int_0^1 W_i(r) dW_i(r)}{\left[\int_0^1 W_i(r)^2 dr \right]^{\frac{1}{2}}} = t_{iT} \quad (20)$$

for fixed N and $T \rightarrow \infty$ where t_{iT} is assumed i.i.d. with finite mean and variance

Im, Pesaran and Shin (IPS) test III

- Asymptotic distribution:

$$t_{IPS} = \frac{\sqrt{N} \left(\bar{t} - \frac{1}{N} \sum_{i=1}^N E[t_{iT} | \rho_i = 0] \right)}{\sqrt{\frac{1}{N} \sum_{i=1}^N \text{var}[t_{iT} | \rho_i = 0]}} \Rightarrow N(0, 1) \quad (21)$$

as $T \rightarrow \infty$ and $N \rightarrow \infty$, by the Lindeberg-Lévy central limit theorem

- $E[t_{iT} | \rho_i = 0]$ and $\text{var}[t_{iT} | \rho_i = 0]$ obtained by simulations for different values of T and p_i 's
- Recommendation:
if lag order is large enough, then IPS outperforms LLC

Breitung's test I

- Breitung (2000)
- Idea:
LLC and IPS have weak power performance with deterministic terms due to bias correction
- Three-step procedure:
 - 1 perform separate augmented Dickey-Fuller (ADF) regressions for each cross-section i :
 - 1.1 determine lag order to completely specify the ADF regression
 - 1.2 get orthogonalized residuals to use Frisch-Waugh theorem, but without using deterministic terms d_{mt}
 - 1.3 standardize residuals to control for different variances across i

Breitung's test II

- 2 transform \tilde{e}_{it} using the forward orthogonalization transformation by Arellano and Bover (1995):

$$e_{it}^* = \sqrt{\frac{T-t}{T-t+1}} \left(\tilde{e}_{it} - \frac{\tilde{e}_{i,t+1} + \dots + \tilde{e}_{i,T}}{T-t} \right) \quad (22)$$

$$\nu_{i,t-1}^* = \begin{cases} \tilde{\nu}_{i,t-1} & \text{without intercept or trend} \\ \tilde{\nu}_{i,t-1} - \tilde{\nu}_{i,1} & \text{with intercept} \\ \tilde{\nu}_{i,t-1} - \tilde{\nu}_{i,1} - \frac{t-1}{T} \tilde{\nu}_{i,T} & \text{with intercept and trend} \end{cases} \quad (23)$$

- 3 run the pooled regression:

$$e_{it}^* = \rho \nu_{i,t-1}^* + \varepsilon_{it}^* \quad (24)$$

→ t-statistic for $H_0 : \rho = 0$, t_ρ^*

- Asymptotic distribution:

$$t_\rho^* \Rightarrow N(0, 1) \quad (25)$$

Combined p-value tests I

- Maddala and Wu (1999) and Choi(2001)
- Let G_{iT_i} be a unit root test statistic for the i th individual
- Assume $G_{iT_i} \Rightarrow G_i$ as $T_i \rightarrow \infty$ where G_i is a nondegenerate random variable
- Let p_i be the corresponding asymptotic p-value
- Test statistic:

$$P = -2 \sum_{i=1}^N \ln p_i \quad (26)$$

which uses the p-values from unit root tests for each cross-section i (e.g. ADF test) \rightarrow "Fisher's inverse chi-square test"

- Asymptotic distribution:

$$P \Rightarrow \chi_{2N}^2 \quad (27)$$

as $T_i \rightarrow \infty$ for finite N

- Improved test statistic:

Combined p-value tests II

- "inverse normal test"

$$Z = \frac{1}{\sqrt{N}} \sum_{i=1}^N \Phi^{-1}(p_i) \quad (28)$$

where Φ is the standard normal cumulative distribution function

- as $0 \leq p_i \leq 1$, $\Phi^{-1}(p_i) \sim N(0, 1)$

- Asymptotic distribution:

$$Z \Rightarrow N(0, 1) \quad (29)$$

as $T_i \rightarrow \infty$ for all i

- Advantages:

- different lag orders may be used
- other unit root tests may be applied

- Disadvantages:

p-values have to be derived by Monte Carlo simulations

- Recommendations:

- for ρ and/or T heterogeneous across i
- combined p-value tests outperform the IPS test, the Z test performs best

Residual-based LM test I

- Hadri (2000)
- Null hypothesis: no unit root in any of the series
- Alternative hypothesis: unit root in the panel
- Model:

$$y_{it} = r_{it} + \beta_i t + \varepsilon_{it} \quad (30)$$

$$r_{it} = r_{i,t-1} + u_{it} \quad (31)$$

where $\varepsilon_{it} \sim i.i.n.(0, \sigma_\varepsilon^2)$ and $u_{it} \sim i.i.n.(0, \sigma_u^2)$ are mutually independent across i and over t

- By back substitution:

$$y_{it} = r_{i0} + \beta_i t + \sum_{s=1}^t u_{is} + \varepsilon_{it} \quad (32)$$

Residual-based LM test II

- Null hypothesis revisited:

$$H_0 : \sigma_u^2 = 0 \quad (33)$$

associated with stationarity

- LM statistic:

$$LM_2 = \frac{1}{N} \left[\sum_{i=1}^N \left(\frac{1}{T^2} \sum_{t=1}^T \frac{S_{it}^2}{\hat{\sigma}_{\varepsilon i}^2} \right) \right] \quad (34)$$

where

$$S_{it} = \sum_{s=1}^t \hat{\varepsilon}_{is} \quad (35)$$

and

$$\hat{\sigma}_{\varepsilon i}^2 = \frac{1}{T} \sum_{t=1}^T \hat{\varepsilon}_{it}^2 \quad (36)$$

which allows for heteroskedasticity across i

Residual-based LM test III

- Test statistic:

$$Z = \sqrt{N} \frac{LM_2 - \xi}{\zeta} \quad (37)$$

where $\xi = 1/15$ and $\zeta = 11/6300$ for the model with constant and trend ($\xi = 1/6$ and $\zeta = 1/45$ with constant only)

- Asymptotic distribution:

$$Z \Rightarrow N(0, 1) \quad (38)$$

Moon and Perron test I

- Moon and Perron (2004)
- Idea: tackle cross-sectional dependence, i.e. control for it
- Null hypothesis:

$$H_0 : \rho_i = 0 \quad \text{for all } i \quad (39)$$

- Alternative hypothesis:

$$H_1 : \rho_i < 0 \quad \text{for some } i \quad (40)$$

- Dynamic factor model:

$$y_{it} = \alpha_i + y_{it}^0 \quad (41)$$

$$y_{it}^0 = \rho_i y_{i,t-1}^0 + \varepsilon_{it} \quad (42)$$

where ε_{it} is generated by M unobservable random factors f_t , such that

$$\varepsilon_{it} = \Lambda_i' f_t + e_{it} \quad (43)$$

where Λ_i is a vector of nonrandom factor loading coefficients of unknown length M

Moon and Perron test II

- Let Q_Λ be the matrix projecting onto the space orthogonal to the factor loadings, purging from cross-sectional dependence; let $\sigma_{e,i}^2$ be the variance of $e_{i,t}$, $w_{e,i}^2$, the long-run variance of e_{it} , and $\lambda_{e,i}$, the one-sided long-run variance of e_{it} ; let σ_e^2 , w_e^2 , and λ_e be their cross-sectional averages, and ϕ_e^4 be the cross-sectional average of $w_{e,i}^4$

- Test statistic:

$$t_a = \frac{\sqrt{NT}(\hat{\rho}_{pool}^+ - 1)}{\sqrt{\frac{2\phi_e^4}{w_e^4}}} \quad (44)$$

where the pooled bias-correlated estimate

$$\hat{\rho}_{pool}^+ = \frac{tr(Y_{-1} Q_\Lambda Y') - NT \lambda_e^N}{tr(Y_{-1} Q_\Lambda Y'_{-1})} \quad (45)$$

where Y is a $T \times N$ matrix of the data, Y_{-1} contains lagged values

Moon and Perron test III

- Asymptotic distribution:

$$t_a \Rightarrow N(0, 1) \quad (46)$$

where $N \rightarrow \infty$ and $T \rightarrow \infty$ such that $N/T \rightarrow 0$